Dual Precision Retriggerable/Resettable Monostable Multivibrator

The MC14538B is a dual, retriggerable, resettable monostable multivibrator. It may be triggered from either edge of an input pulse, and produces an accurate output pulse over a wide range of widths, the duration and accuracy of which are determined by the external timing components, C_X and R_X . Output Pulse Width $T = R_X \cdot C_X$ (secs)

$$R_X = \Omega$$

 $C_X = Farads$

Features

- Unlimited Rise and Fall Time Allowed on the A Trigger Input
- Pulse Width Range = $10 \ \mu s$ to $10 \ s$
- Latched Trigger Inputs
- Separate Latched Reset Inputs
- 3.0 Vdc to 18 Vdc Operational Limits
- Triggerable from Positive (A Input) or Negative–Going Edge (B–Input)
- Capable of Driving Two Low–Power TTL Loads or One Low–Power Schottky TTL Load Over the Rated Temperature Range
- Pin-for-pin Compatible with MC14528B and CD4528B (CD4098)
- Use the MC54/74HC4538A for Pulse Widths Less Than 10 μs with Supplies Up to 6 V
- Pb–Free Packages are Available*

MAXIMUM RATINGS (Voltages Referenced to V_{SS})

Symbol	Parameter	Value	Unit	
V _{DD}	DC Supply Voltage Range	-0.5 to +18.0	V	
V _{in} , V _{out}	Input or Output Voltage Range (DC or Transient)	–0.5 to V _{DD} + 0.5	V	
I _{in} , I _{out}	Input or Output Current (DC or Transient) per Pin	±10	mA	
PD	Power Dissipation, per Package (Note 1)	500	mW	
T _A	Operating Temperature Range	-55 to +125	°C	
T _{stg}	Storage Temperature Range	-65 to +150	°C	
TL	Lead Temperature (8–Second Soldering)	260	°C	

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

1. Temperature Derating:

Plastic "P and D/DW" Packages: - 7.0 mW/°C From 65°C To 125°C

This device contains protection circuitry to guard against damage due to high static voltages or electric fields. However, precautions must be taken to avoid applications of any voltage higher than maximum rated voltages to this high–impedance circuit. For proper operation, V_{in} and V_{out} should be constrained to the range $V_{SS} \leq (V_{in} \text{ or } V_{out}) \leq V_{DD}.$

Unused inputs must always be tied to an appropriate logic voltage level (e.g., either V_{SS} or V_{DD}). Unused outputs must be left open.

Semiconductor Components Industries, LLC, 2005 August, 2005 – Rev. 7



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		MARKING DIAGRAMS
	PDIP-16 P SUFFIX CASE 648	16 <u>ኩሉሉሉሉሉ</u> MC14538BCP o AWLYYWWG 1 ውውውውውው
STREE STREET	SOIC-16 D SUFFIX CASE 751B	16 14538BG ○ AWLYWW □□□□□□□□ 1
C) ANA	SOIC-16 DW SUFFIX CASE 751G	16
- Annan	TSSOP-16 DT SUFFIX CASE 948F	16 14 538B o ALYW 1
CALING AND	SOEIAJ–16 F SUFFIX CASE 966	16
A WL, YY, WW G	L = Wafer Y = Year , W = Work	

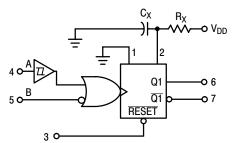
ORDERING INFORMATION

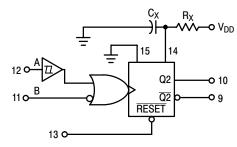
See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

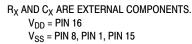
*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

Publication Order Number: MC14538B/D

BLOCK DIAGRAM



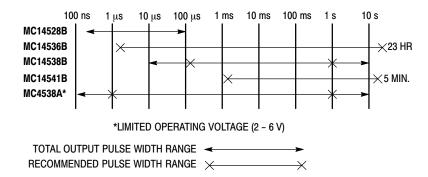




16 🛛 V_{DD} V_{SS} 1. C_X/R_XA 2 15 Vss RESET A 3 14 C_X/R_XB 13 🛛 RESET B A_A 4 BA 12 🛛 A_B 5 Q_A 6 11 🛛 🖥 🖥 Q_A 10 D QB 7 9 🛛 🗖 🗛 V_{SS} [] 8

PIN ASSIGNMENT

ONE-SHOT SELECTION GUIDE



ORDERING INFORMATION

Device	Package	Shipping [†]	
MC14538BCP	PDIP-16	500 Units / Rail	
MC14538BCPG	PDIP-16 (Pb-Free)	500 Units / Rail	
MC14538BD	SOIC-16	48 Units / Rail	
MC14538BDG	SOIC-16 (Pb-Free)	48 Units / Rail	
MC14538BDR2	SOIC-16	2500 Units / Tape & Reel	
MC14538BDR2G	SOIC-16 (Pb-Free)	2500 Units / Tape & Reel	
MC14538BDW	SOIC-16 WB	47 Units / Rail	
MC14538BDWR2	SOIC-16 WB	1000 Units / Tape & Reel	
MC14538BDWR2G	SOIC-16 WB (Pb-Free)	1000 Units / Tape & Reel	
MC14538BDTR2	TSSOP-16*	2500 Units / Tape & Reel	
MC14538BF	SOEIAJ-16	50 Units / Rail	
MC14538BFG	SOEIAJ-16 (Pb-Free)	50 Units / Rail	
MC14538BFEL	SOEIAJ-16	2000 Units / Tape & Reel	
MC14538BFELG	SOEIAJ-16 (Pb-Free)	2000 Units / Tape & Reel	

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

*This package is inherently Pb-Free.

ELECTRICAL CHARACTERISTICS (Voltages Referenced to V_{SS})

		V	– 55°C		25°C			125°C		
Characteristic	Symbol	V _{DD} Vdc	Min	Max	Min	Typ (Note 2)	Max	Min	Max	Unit
Output Voltage "0" Leve $V_{in} = V_{DD}$ or 0	V _{OL}	5.0 10 15	- - -	0.05 0.05 0.05	- - -	0 0 0	0.05 0.05 0.05	- - -	0.05 0.05 0.05	Vdc
"1" Leve $V_{in} = 0 \text{ or } V_{DD}$	V _{OH}	5.0 10 15	4.95 9.95 14.95	- - -	4.95 9.95 14.95	5.0 10 15	- - -	4.95 9.95 14.95	- - -	Vdc
Input Voltage "0" Leve $(V_O = 4.5 \text{ or } 0.5 \text{ Vdc})$ $(V_O = 9.0 \text{ or } 1.0 \text{ Vdc})$ $(V_O = 13.5 \text{ or } 1.5 \text{ Vdc})$	VIL	5.0 10 15	_ _ _	1.5 3.0 4.0	_ _ _	2.25 4.50 6.75	1.5 3.0 4.0	_ _ _	1.5 3.0 4.0	Vdc
"1" Leve (V _O = 0.5 or 4.5 Vdc) (V _O = 1.0 or 9.0 Vdc) (V _O = 1.5 or 13.5 Vdc)	V _{IH}	5.0 10 15	3.5 7.0 11	- - -	3.5 7.0 11	2.75 5.50 8.25	- - -	3.5 7.0 11	_ _ _	Vdc
$\begin{array}{l} \text{Output Drive Current} \\ (V_{OH} = 2.5 \ \text{Vdc}) \\ (V_{OH} = 4.6 \ \text{Vdc}) \\ (V_{OH} = 9.5 \ \text{Vdc}) \\ (V_{OH} = 13.5 \ \text{Vdc}) \end{array}$	Іон	5.0 5.0 10 15	- 3.0 - 0.64 - 1.6 - 4.2	- - -	- 2.4 - 0.51 - 1.3 - 3.4	- 4.2 - 0.88 - 2.25 - 8.8	- - -	- 1.7 - 0.36 - 0.9 - 2.4		mAdc
	I _{OL}	5.0 10 15	0.64 1.6 4.2	_ _ _	0.51 1.3 3.4	0.88 2.25 8.8		0.36 0.9 2.4	_ _ _	mAdc
Input Current, Pin 2 or 14	l _{in}	15	-	±0.05	-	±0.00001	±0.05	_	±0.5	μAdc
Input Current, Other Inputs	l _{in}	15	-	±0.1	-	±0.00001	±0.1	_	±1.0	μAdc
Input Capacitance, Pin 2 or 14	C _{in}	-	-	-	-	25	-	_	-	pF
Input Capacitance, Other Inputs (V _{in} = 0)	C _{in}	-	-	-	-	5.0	7.5	-	-	pF
Quiescent Current (Per Package) $Q = Low, \overline{Q} = High$	I _{DD}	5.0 10 15	- - -	5.0 10 20	- - -	0.005 0.010 0.015	5.0 10 20	- - -	150 300 600	μAdc
Quiescent Current, Active State (Both) (Per Package) $Q = High, \overline{Q} = Low$	I _{DD}	5.0 10 15	- - -	2.0 2.0 2.0	- - -	0.04 0.08 0.13	0.20 0.45 0.70	- - -	2.0 2.0 2.0	mAdc
Total Supply Current at an external load capacitance (C_L) and at external timing network (R_X , C_X) (Note 3)	IT	5.0 10		$I_{T} = (8.0)$ $I_{T} = (1.25)$	x 10 ⁻²) R 5 x 10 ⁻¹) I _T in μA (C _X in μF,	$_{\chi}C_{\chi}f + 4C_{\chi}f + 4C_{\chi}f + 2C_{\chi}f + 9C_{\chi}f + 12C_{\chi}C_{\chi}f + 12C_{\chi}f + 12C_{\chi$	+ 2 x 10 ⁻ $X_{X}f$ + 3 x 1 able switch in k ohm	⁵ C _L f 0 ^{–5} C _L f hing only),		μAdc

Data labelled "Typ" is not to be used for design purposes but is intended as an indication of the IC's potential performance.
 The formulas given are for the typical characteristics only at 25°C.

SWITCHING CHARACTERISTICS (Note 4) ($C_L = 50 \text{ pF}, T_A = 25^{\circ}C$)

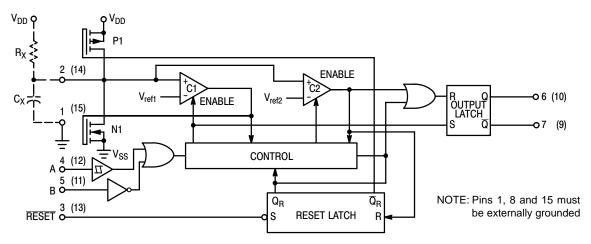
		v				
Characteristic	Symbol	V _{DD} Vdc	Min	Typ (Note 5)	Max	Unit
Output Rise Time $t_{TLH} = (1.35 \text{ ns/pF}) C_L + 33 \text{ ns}$ $t_{TLH} = (0.60 \text{ ns/pF}) C_L + 20 \text{ ns}$ $t_{TLH} = (0.40 \text{ ns/pF}) C_L + 20 \text{ ns}$	t _{TLH}	5.0 10 15		100 50 40	200 100 80	ns
Output Fall Time $t_{THL} = (1.35 \text{ ns/pF}) C_L + 33 \text{ ns}$ $t_{THL} = (0.60 \text{ ns/pF}) C_L + 20 \text{ ns}$ $t_{THL} = (0.40 \text{ ns/pF}) C_L + 20 \text{ ns}$	t _{THL}	5.0 10 15		100 50 40	200 100 80	ns
Propagation Delay Time A or B to Q or \overline{Q} t_{PLH} , $t_{PHL} = (0.90 \text{ ns/pF}) C_L + 255 \text{ ns}$ t_{PLH} , $t_{PHL} = (0.36 \text{ ns/pF}) C_L + 132 \text{ ns}$ t_{PLH} , $t_{PHL} = (0.26 \text{ ns/pF}) C_L + 87 \text{ ns}$	t _{PLH} , t _{PHL}	5.0 10 15		300 150 100	600 300 220	ns
$\label{eq:Reset} \begin{array}{l} \overline{\text{Reset}} \text{ to } Q \text{ or } \overline{Q} \\ t_{\text{PLH}}, t_{\text{PHL}} = (0.90 \text{ ns/pF}) \text{ C}_{\text{L}} + 205 \text{ ns} \\ t_{\text{PLH}}, t_{\text{PHL}} = (0.36 \text{ ns/pF}) \text{ C}_{\text{L}} + 107 \text{ ns} \\ t_{\text{PLH}}, t_{\text{PHL}} = (0.26 \text{ ns/pF}) \text{ C}_{\text{L}} + 82 \text{ ns} \end{array}$		5.0 10 15		250 125 95	500 250 190	ns
Input Rise and Fall Times Reset	t _r , t _f	5 10 15	- - -		15 5 4	μs
B Input		5 10 15		300 1.2 0.4	1.0 0.1 0.05	ms
A Input		5 10 15		No Limit		-
Input Pulse Width A, B, or Reset	t _{WH} , t _{WL}	5.0 10 15	170 90 80	85 45 40	- - -	ns
Retrigger Time	t _{rr}	5.0 10 15	0 0 0		- - -	ns
Output Pulse Width — Q or \overline{Q} Refer to Figures 8 and 9 $C_X = 0.002 \ \mu\text{F}, R_X = 100 \ \text{k}\Omega$	Т	5.0 10 15	198 200 202	210 212 214	230 232 234	μs
C_X = 0.1 $\mu\text{F},\text{R}_X$ = 100 k Ω		5.0 10 15	9.3 9.4 9.5	9.86 10 10.14	10.5 10.6 10.7	ms
C_X = 10 μ F, R _X = 100 k Ω		5.0 10 15	0.91 0.92 0.93	0.965 0.98 0.99	1.03 1.04 1.06	S
Pulse Width Match between circuits in the same package. $C_X = 0.1 \ \mu$ F, $R_X = 100 \ k\Omega$	100 [(T ₁ – T ₂)/T ₁]	5.0 10 15	- - -	± 1.0 ± 1.0 ± 1.0	± 5.0 ± 5.0 ± 5.0	%

The formulas given are for the typical characteristics only at 25°C.
 Data labelled "Typ" is not to be used for design purposes but is intended as an indication of the IC's potential performance.

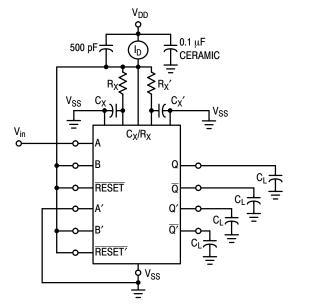
OPERATING CONDITIONS

External Timing Resistance	R _X	-	5.0	-	(Note 6)	kΩ
External Timing Capacitance	C _X	-	0	-	No Limit (Note 7)	μF

6. The maximum usable resistance R_X is a function of the leakage of the capacitor C_X, leakage of the MC14538B, and leakage due to board layout and surface resistance. Susceptibility to externally induced noise signals may occur for R_X > 1 MΩ..
7. If C_X > 15 µF, use discharge protection diode per Fig. 11.







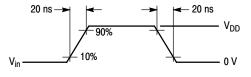


Figure 2. Power Dissipation Test Circuit and Waveforms

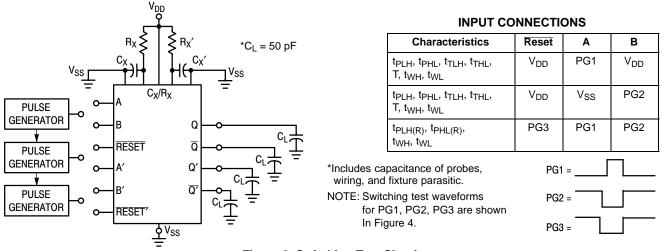


Figure 3. Switching Test Circuit

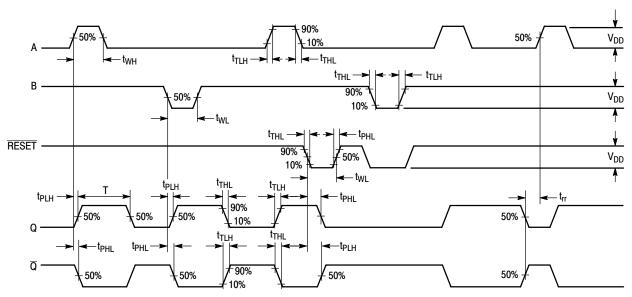
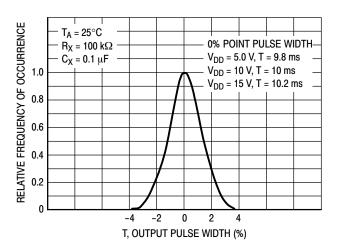


Figure 4. Switching Test Waveforms





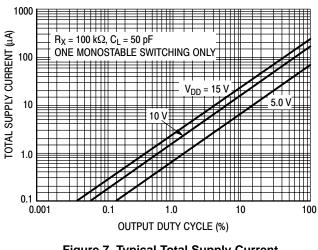


Figure 7. Typical Total Supply Current versus Output Duty Cycle

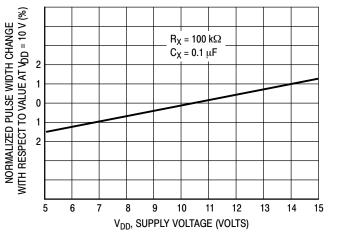


Figure 6. Typical Pulse Width Variation as a Function of Supply Voltage V_{DD}

FUNCTION TABLE						
	Inputs	Out	puts			
Reset	Α	В	Q	Q		
Н	7	Н	Л	Л		
Н	L	\sim	Л	Ţ		
Н	$\sim \sim$	L	Not Triggered			
Н	Н	ノヘ	Not Triggered			
Н	L, H, 🔨	Н	Not Tri	ggered		
Н	L	L, H, 🖌	Not Triggered			
L	Х	Х	L	Н		
$\sim \checkmark$	Х	Х	Not Triggered			

FUNCTION TABLE

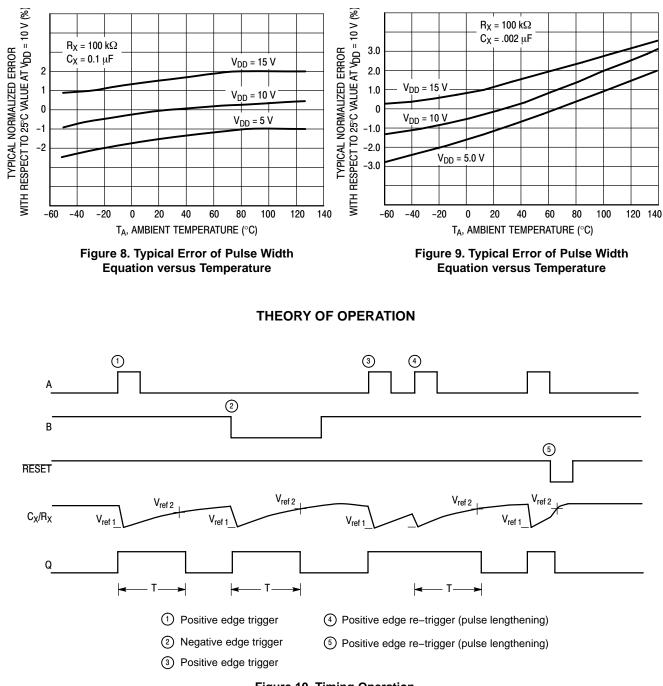


Figure 10. Timing Operation

TRIGGER OPERATION

The block diagram of the MC14538B is shown in Figure 1, with circuit operation following.

As shown in Figure 1 and 10, before an input trigger occurs, the monostable is in the quiescent state with the Q output low, and the timing capacitor CX completely charged to V_{DD} . When the trigger input A goes from V_{SS} to V_{DD} (while inputs B and Reset are held to V_{DD}) a valid trigger is recognized, which turns on comparator C1 and N-channel transistor N1 1. At the same time the output latch is set. With transistor N1 on, the capacitor CX rapidly discharges toward V_{SS} until V_{ref1} is reached. At this point the output of comparator C1 changes state and transistor N1 turns off. Comparator C1 then turns off while at the same time comparator C2 turns on. With transistor N1 off, the capacitor C_X begins to charge through the timing resistor, R_X , toward V_{DD} . When the voltage across C_X equals V_{ref2} , comparator C2 changes state, causing the output latch to reset (Q goes low) while at the same time disabling comparator C2 2. This ends at the timing cycle with the monostable in the quiescent state, waiting for the next trigger.

In the quiescent state, C_X is fully charged to V_{DD} causing the current through resistor R_X to be zero. Both comparators are "off" with total device current due only to reverse junction leakages. An added feature of the MC14538B is that the output latch is set via the input trigger without regard to the capacitor voltage. Thus, propagation delay from trigger to Q is independent of the value of C_X , R_X , or the duty cycle of the input waveform.

RETRIGGER OPERATION

The MC14538B is retriggered if a valid trigger occurs ⁽³⁾ followed by another valid trigger ⁽⁴⁾ before the Q output has returned to the quiescent (zero) state. Any retrigger, after the timing node voltage at pin 2 or 14 has begun to rise from $V_{ref 1}$, but has not yet reached $V_{ref 2}$, will cause an increase in output pulse width T. When a valid retrigger is initiated ⁽⁴⁾, the voltage at C_X/R_X will again drop to $V_{ref 1}$ before progressing along the RC charging curve toward V_{DD} . The Q output will remain high until time T, after the last valid retrigger.

RESET OPERATION

The MC14538B may be reset during the generation of the output pulse. In the reset mode of operation, an input pulse

on Reset sets the reset latch and causes the capacitor to be fast charged to V_{DD} by turning on transistor P1 ⁽⁵⁾. When the voltage on the capacitor reaches $V_{ref 2}$, the reset latch will clear, and will then be ready to accept another pulse. It the Reset input is held low, any trigger inputs that occur will be inhibited and the Q and \overline{Q} outputs of the output latch will not change. Since the Q output is reset when an input low level is detected on the Reset input, the output pulse T can be made significantly shorter than the minimum pulse width specification.

POWER-DOWN CONSIDERATIONS

Large capacitance values can cause problems due to the large amount of energy stored. When a system containing the MC14538B is powered down, the capacitor voltage may discharge from V_{DD} through the standard protection diodes at pin 2 or 14. Current through the protection diodes should be limited to 10 mA and therefore the discharge time of the V_{DD} supply must not be faster than (V_{DD}) . (C)/(10 mA). For example, if $V_{DD} = 10$ V and $C_X = 10 \,\mu\text{F}$, the V_{DD} supply should discharge no faster than $(10 \text{ V}) \times (10 \,\mu\text{F})/(10 \text{ mA}) = 10$ ms. This is normally not a problem since power supplies are heavily filtered and cannot discharge at this rate.

When a more rapid decrease of V_{DD} to zero volts occurs, the MC14538B can sustain damage. To avoid this possibility use an external clamping diode, D_X , connected as shown in Fig. 11.

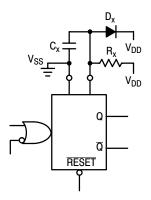
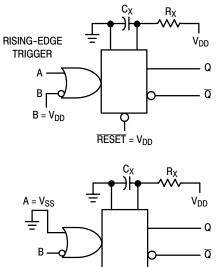


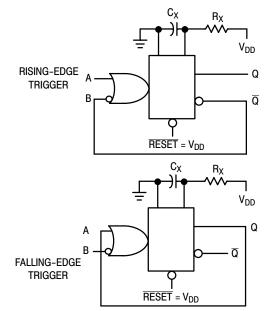
Figure 11. Use of a Diode to Limit Power Down Current Surge

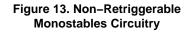
TYPICAL APPLICATIONS











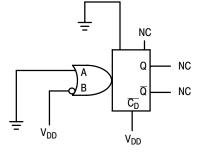
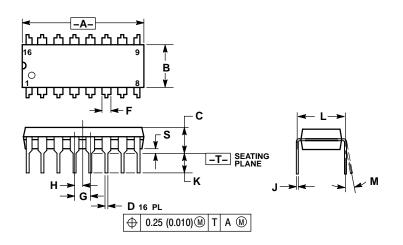


Figure 14. Connection of Unused Sections

PACKAGE DIMENSIONS

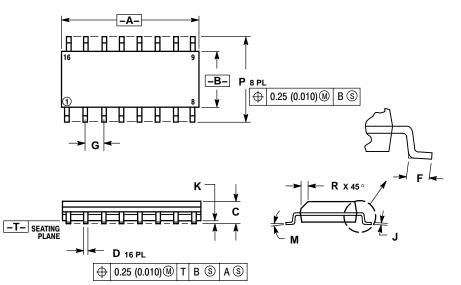
PDIP-16 **P SUFFIX** PLASTIC DIP PACKAGE CASE 648-08 ISSUE T



- NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH. 3. DIMENSION L TO CENTER OF LEADS WHEN FORMED PARALLEL. 4. DIMENSION B DOES NOT INCLUDE MOLD FLASH. 5. ROUNDED CORNERS OPTIONAL.

	INC	HES	MILLIN	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.740	0.770	18.80	19.55	
В	0.250	0.270	6.35	6.85	
С	0.145	0.175	3.69	4.44	
D	0.015	0.021	0.39	0.53	
F	0.040	0.70	1.02	1.77	
G	0.100	BSC	2.54	BSC	
н	0.050	BSC	1.27 BSC		
J	0.008	0.015	0.21	0.38	
ĸ	0.110	0.130	2.80	3.30	
L	0.295	0.305	7.50	7.74	
M	0 °	10 °	0 °	10 °	
S	0.020	0.040	0.51	1.01	

SOIC-16 **D SUFFIX** PLASTIC SOIC PACKAGE CASE 751B-05 ISSUE J



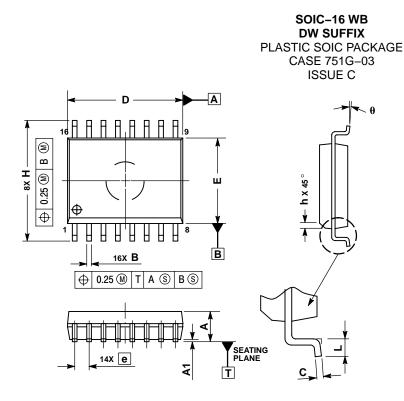
NOTES:

- NO LES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: MILLIMETER. 3. DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION. 4. MAXIMUM MOLD PROTRUSION 0.15 (0.006) DED 0100

- PER SIDE. 5. DIMENSION D DOES NOT INCLUDE DAMBAR
- PROTRUSION & DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.

	MILLIMETERS		INC	HES	
DIM	MIN	MAX	MIN	MAX	
Α	9.80	10.00	0.386	0.393	
В	3.80	4.00	0.150	0.157	
C	1.35	1.75	0.054	0.068	
D	0.35	0.49	0.014	0.019	
F	0.40	1.25	0.016	0.049	
G	1.27	BSC	0.050 BSC		
J	0.19	0.25	0.008	0.009	
K	0.10	0.25	0.004	0.009	
Μ	0 °	7°	0 °	7°	
Р	5.80	6.20	0.229	0.244	
R	0.25	0.50	0.010	0.019	

PACKAGE DIMENSIONS

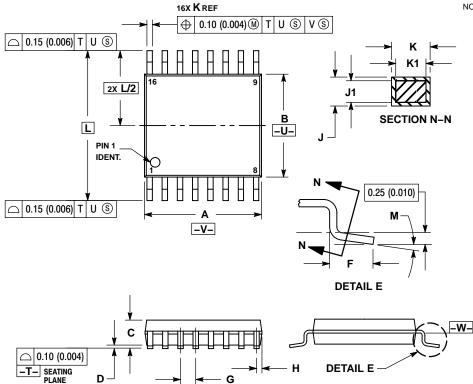


NOTES:

- NOTES:
 DIMENSIONS ARE IN MILLIMETERS.
 INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994.
 DIMENSIONS D AND E DO NOT INLCUDE MOLD PROTRUSION.
 MAXIMUM MOLD PROTRUSION 0.15 PER SIDE.
 DIMENSION B DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION. ALLOWABLE DAMBAR
- PROTRUSION SHALL BE 0.13 TOTAL IN EXCESS OF THE B DIMENSION AT MAXIMUM MATERIAL CONDITION.

	MILLIMETERS				
DIM	MIN	MAX			
Α	2.35	2.65			
A1	0.10	0.25			
В	0.35	0.49			
С	0.23	0.32			
D	10.15	10.45			
Е	7.40	7.60			
е	1.27	BSC			
н	10.05	10.55			
h	0.25	0.75			
L	0.50	0.90			
q	0 °	7 °			

TSSOP-16 **DT SUFFIX** PLASTIC TSSOP PACKAGE CASE 948F-01 **ISSUE A**

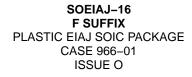


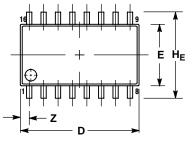
NOTES:

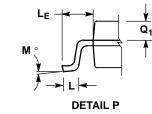
- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: MILLIMETER.
 DIMENSION A DOES NOT INCLUDE MOLD FLASH. PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS SHALL NOT EVECTOR of 16 (0 000 PER SIDE) DIMENSIONING AND TOLERANCING PER
- EXCEED 0.15 (0.006) PER SIDE. 4. DIMENSION B DOES NOT INCLUDE
- INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL
- NOT EXCEED 0.25 (0.010) PRO INUSION S NOT EXCEED 0.25 (0.010) PER SIDE. 5. DIMENSION K DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE K DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 6. TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY. 7. DIMENSION A AND B ARE TO BE DETERMINED AT DATUM PLANE –W–. 6.

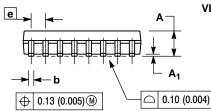
	MILLIN	IETERS	INC	HES	
DIM	MIN	MAX	MIN	MAX	
Α	4.90	5.10	0.193	0.200	
В	4.30	4.50	0.169	0.177	
С		1.20		0.047	
D	0.05	0.15	0.002	0.006	
F	0.50	0.75	0.020	0.030	
G	0.65	BSC	0.026 BSC		
н	0.18	0.28	0.007	0.011	
J	0.09	0.20	0.004	0.008	
J1	0.09	0.16	0.004	0.006	
ĸ	0.19	0.30	0.007	0.012	
K1	0.19	0.25	0.007	0.010	
L	6.40	BSC	0.252	BSC	
М	0 °	8 °	0 °	8 °	

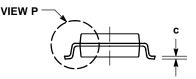
PACKAGE DIMENSIONS











NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- 2. CONTROLLING DIMENSION: MILLIMETER
- 3. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH OR PROTRUSIONS AND ARE
- MOLD FLASH OR PROTRUSIONS AND ARE MEASURED AT THE PARTING LINE. MOLD FLASH OR PROTRUSIONS SHALL NOT EXCEED 0.15
- (0.006) PER SIDE. 4. TERMINAL NUMBERS ARE SHOWN FOR DEEEDENCE ONLY

REFERENCE ONLY. 5. THE LEAD WIDTH DIMENSION (b) DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE LEAD WIDTH DIMENSION AT MAXIMUM MATERIAL CONDITION. DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OR THE FOOT. MINIMUM SPACE BETWEEN PROTRUSIONS AND ADJACENT LEAD TO BE 0.46 (0.018).

		,		
	MILLIN	IETERS	INC	HES
DIM	MIN	MAX	MIN	MAX
Α		2.05		0.081
A ₁	0.05	0.20	0.002	0.008
b	0.35	0.50	0.014	0.020
C	0.18	0.27	0.007	0.011
D	9.90	10.50	0.390	0.413
Е	5.10	5.45	0.201	0.215
е	1.27	BSC	0.050	BSC
HE	7.40	8.20	0.291	0.323
L	0.50	0.85	0.020	0.033
LE	1.10	1.50	0.043	0.059
Μ	0 °	10 °	0 °	10 °
Q ₁	0.70	0.90	0.028	0.035
Z		0.78		0.031

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